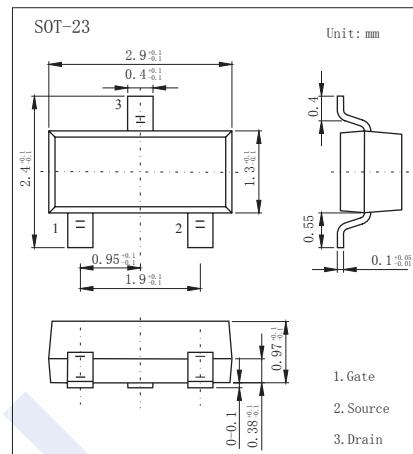


P-Channel Enhancement MOSFET

KI005P

■ Features

- V_{DS} (V) = -20V
- I_D = -2.8 A
- $R_{DS(ON)} < 115\text{m}\Omega$ ($V_{GS} = -4.5\text{V}$)
- $R_{DS(ON)} < 160\text{m}\Omega$ ($V_{GS} = -2.5\text{V}$)



■ Absolute Maximum Ratings $T_a = 25^\circ\text{C}$

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V_{DS}	-20	V
Gate-Source Voltage	V_{GS}	± 12	
Continuous Drain Current	I_D	-2.8	A
Power Dissipation	P_D	1.2	W
Junction Temperature	T_J	150	$^\circ\text{C}$
Junction and Storage Temperature Range	T_{STG}	-55 to 150	

■ Electrical Characteristics $T_a = 25^\circ\text{C}$

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	V_{DSS}	$I_D = -250\text{\mu A}$, $V_{GS} = 0\text{V}$	-20			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = -12\text{V}$, $V_{GS} = 0\text{V}$, $T_j = 25^\circ\text{C}$			1	\mu A
Gate-Body leakage current	I_{GSS}	$V_{DS} = 0\text{V}$, $V_{GS} = \pm 12\text{V}$			± 100	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}$, $I_D = -250\text{\mu A}$	-0.4	-0.7	-1.1	V
Static Drain-Source On-Resistance	$R_{DS(on)}$	$V_{GS} = -4.5\text{V}$, $I_D = -1\text{A}$			115	$\text{m}\Omega$
		$V_{GS} = -2.5\text{V}$, $I_D = -0.5\text{A}$			160	

■ Marking

Marking	005P
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